

ISL9R860P2, ISL9R860S2, ISL9R860S3S

8A, 600V Stealth™ Diode

General Description

The ISL9R860P2, ISL9R860S2 and ISL9R860S3S are Stealth™ diodes optimized for low loss performance in high frequency hard switched applications. The Stealth™ family exhibits low reverse recovery current (I_{RRM}) and exceptionally soft recovery under typical operating conditions.

This device is intended for use as a free wheeling or boost diode in power supplies and other power switching applications. The low I_{RRM} and short t_a phase reduce loss in switching transistors. The soft recovery minimizes ringing, expanding the range of conditions under which the diode may be operated without the use of additional snubber circuitry. Consider using the Stealth™ diode with an SMPS IGBT to provide the most efficient and highest power density design at lower cost.

Formerly developmental type TA49409.

Features

- $\begin{array}{lll} \bullet & \text{Soft Recovery.} & & & t_b \, / \, t_a > 2.5 \\ \bullet & \text{Fast Recovery.} & & & t_{rr} < 25 \text{ns} \\ \bullet & \text{Operating Temperature.} & & & 175 \, ^{\circ}\text{C} \\ \bullet & \text{Reverse Voltage.} & & & 600 \text{V} \\ \end{array}$
- · Avalanche Energy Rated

Applications

- Switch Mode Power Supplies
- · Hard Switched PFC Boost Diode
- UPS Free Wheeling Diode
- · Motor Drive FWD
- SMPS FWD
- · Snubber Diode

Package Symbol JEDEC TO-263AB JEDEC TO-220AC JEDEC STYLE TO-262 Κ ANODE ANODE CATHODE CATHODE **CATHODE** CATHODE (FLANGE) (FLANGE) CATHODE (FLANGE) ANODE

Device Maximum Ratings T_C= 25°C unless otherwise noted

Symbol	Parameter	Ratings	
V _{RRM}	Peak Repetitive Reverse Voltage	600	V
V _{RWM}	Working Peak Reverse Voltage	600	V
V _R	DC Blocking Voltage	600	V
I _{F(AV)}	Average Rectified Forward Current (T _C = 147°C)	8	Α
I _{FRM}	Repetitive Peak Surge Current (20kHz Square Wave)	16	Α
I _{FSM}	Nonrepetitive Peak Surge Current (Halfwave 1 Phase 60Hz)	100	Α
P _D	Power Dissipation	85	W
E _{AVL}	Avalanche Energy (1A, 40mH)	20	mJ
T _J , T _{STG}	Operating and Storage Temperature Range	-55 to 175	°C
TL	Maximum Temperature for Soldering		
T_{PKG}	Leads at 0.063in (1.6mm) from Case for 10s	300	°C
	Package Body for 10s, See Techbrief TB334	260	°C

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

Package	Marking	and	Orderina	Information
		٠٠	0.409	

Device Marking	Device	Package	Tape Width	Quantity
R860P2	ISL9R860P2	TO-220AC	-	-
R860S2	ISL9R860S2	TO-262	-	-
R860S3S	ISL9R860S3S	TO-263AB	24mm	800

Electrical Characteristics T_C = 25°C unless otherwise noted

Symbol	Parameter	Test C	onditions	Min	Тур	Max	Units
Off State	Characteristics						
I _R	Instantaneous Reverse Current	V _R = 600V	T _C = 25°C	-	-	100	μΑ
IX.			T _C = 125°C	-	-	1.0	mA
On State	Characteristics						
V _F	Instantaneous Forward Voltage	I _F = 8A	T _C = 25°C	-	2.0	2.4	V
			T _C = 125°C	-	1.6	2.0	V
Dynamic	Characteristics						
CJ	Junction Capacitance	V _R = 10V, I _F = 0A	1	-	30	-	pF
Switching	Characteristics						
`	t _{rr} Reverse Recovery Time		$I_{-} = 1A dI_{-}/dt = 100A/us V_{-} = 30V$		18	25	ns
71				-	21	30	ns
t _{rr}	Reverse Recovery Time	I _F = 8A,		-	28	-	ns
I _{RRM}	Maximum Reverse Recovery Current	$dI_F/dt = 200A/\mu s,$ $V_R = 390V, T_C = 25^{\circ}C$ $I_F = 8A,$ $dI_F/dt = 200A/\mu s,$ $V_R = 390V,$ $T_C = 125^{\circ}C$		-	3.2	-	Α
Q _{RR}	Reverse Recovery Charge			-	50	-	nC
t _{rr}	Reverse Recovery Time			-	77	-	ns
S	Softness Factor (t _b /t _a)			-	3.7	-	
I _{RRM}	Maximum Reverse Recovery Current			-	3.4	-	Α
Q _{RR}	Reverse Recovery Charge			-	150	-	nC
t _{rr}	Reverse Recovery Time	I _F = 8A,		-	53	-	ns
S	Softness Factor (t _b /t _a)	dI _F /dt = 600A/μs, V _R = 390V, - T _C = 125°C		-	2.5	-	
I _{RRM}	Maximum Reverse Recovery Current			-	6.5	-	Α
Q _{RR}	Reverse Recovery Charge				195	-	nC
dl _M /dt	Maximum di/dt during t _b			-	500	-	A/µs
Thermal	Characteristics						
$R_{\theta JC}$	Thermal Resistance Junction to Case	T		_	_	1.75	°C/W
$R_{\theta JA}$	Thermal Resistance Junction to Ambient	nt TO-220		-	-	62	°C/W
$R_{\theta JA}$	Thermal Resistance Junction to Ambient			-	-	62	°C/W
$R_{\theta JA}$	Thermal Resistance Junction to Ambient	nt TO-263				62	°C/W

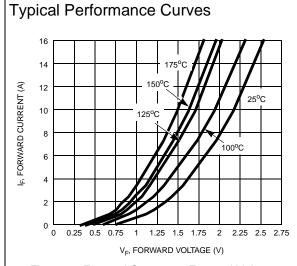
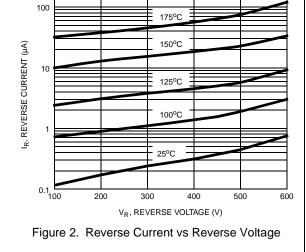


Figure 1. Forward Current vs Forward Voltage



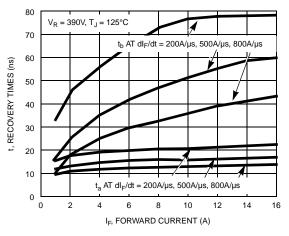


Figure 3. t_a and t_b Curves vs Forward Current

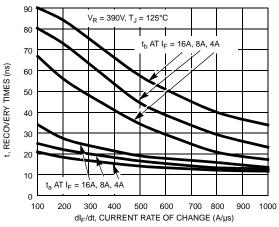


Figure 4. t_a and t_b Curves vs dI_F/dt

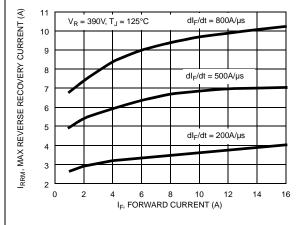


Figure 5. Maximum Reverse Recovery Current vs Forward Current

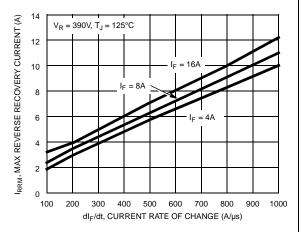
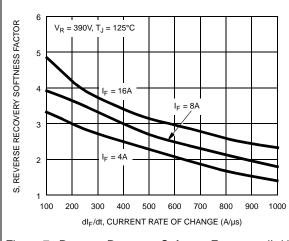


Figure 6. Maximum Reverse Recovery Current vs dI_F/dt

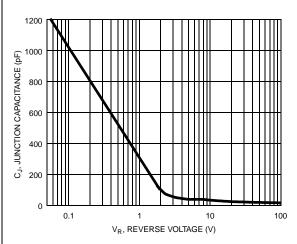


Typical Performance Curves (Continued)

350 V_R = 390V, T_J = 125°C Q_{RR}, REVERSE RECOVERY CHARGE (nC) 300 I_F = 16A 250 I_F = 8A 200 150 $I_F = 4A$ 100 100 400 500 600 700 800 900 1000 dl_E/dt, CURRENT RATE OF CHANGE (A/µs)

Figure 7. Reverse Recovery Softness Factor vs dl_F/dt

Figure 8. Reverse Recovery Charge vs dl_F/dt



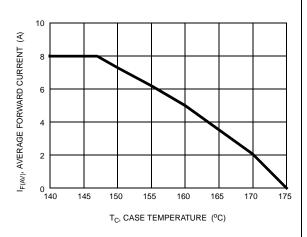


Figure 9. Junction Capacitance vs Reverse Voltage

Figure 10. DC Current Derating Curve

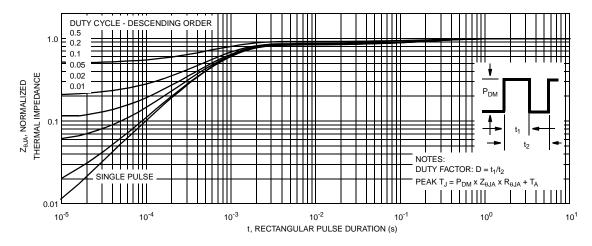
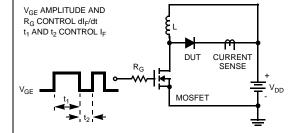


Figure 11. Normalized Maximum Transient Thermal Impedance

Test Circuits and Waveforms



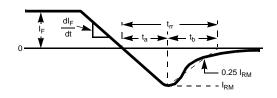


Figure 12. t_{rr} Test Circuit

Figure 13. t_{rr} Waveforms and Definitions

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I = 1A
L = 40 \text{mH}
R < 0.1\Omega
V_{DD} = 50V
E_{AVL} = 1/2LI^2 \left[V_{R(AVL)}/(V_{R(AVL)} - V_{DD})\right]
Q_1 = IGBT \left(BV_{CES} > DUT \ V_{R(AVL)}\right)
Q_1 = IGBT \left(BV_{CES} > DUT \ V_{R(AVL)}\right)
U_{DD} = V_{DD}
V_{DD} = V_{DD}
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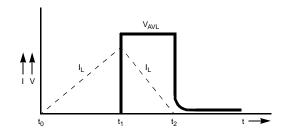


Figure 14. Avalanche Energy Test Circuit

Figure 15. Avalanche Current and Voltage Waveforms

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Definition of Terms

Datasheet Identification	Product Status	Definition		
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Preliminary	First Production	This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.		
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